Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/683,666	YEO ET AL.	
Examiner	**Art Unit**	
Toan Ton	2871	

SEARCHED			
Class	Subclass	Date	Examiner
349	139	7/12/2005	TTON
	43		
	46		
	38		
	187		
257	59		
	72		

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
349	**38,43,46**	7/12/2005	**TTON**
	187,139		
257	59,72		

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
EAST liquid crystal thin film transistor dummy gate electrode gate insulat$ drain/source electrode insulat$ contact hole	7/12/2005	TTON
extend$		